Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/005,299	QIN, JIAN	
Examiner	Art Unit	
Michele Kidwell	3761	

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Class	Subclass	Date	Examiner
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INTE	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search	9/27/2005	MK		